

Notice of References Cited	Application/Control No. 09/868,573	Applicant(s)/Patent Under Examination LEN, MITSUO	
	Examiner Lynne Edmondson	Art Unit 1725	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,774,427 ✕	11-1973	Schreiner et al.	228/110.1
*	B	US-5,232,562	08-1993	Elliott, Donald A.	204/224R
*	C	US-3,883,946	05-1975	Dale, John Robert	228/121
*	D	US-4,978,052	12-1990	Fister et al.	156/325
*	E	US-6,250,984	06-2001	Jin et al.	313/306
	F	US-6,165,819 ✕	12-2000	Seki et al.	228/180.1
	G	US-5,521,432 ✕	05-1996	Tsuji et al.	228/13
	H	US-4,331,258 ✕	05-1982	Geschwind, Gary I.	106/14.15
	I	US-6,353,540 ✕	03-2002	Akiba et al.	361/794
	J	US-RE34,484 ✕	12-1993	Nagashima et al.	428/621
	K	US-6,390,353 ✕	05-2002	Lichtenberger, Heiner	228/173.1
	L	US-6,316,832 ✕	11-2001	Tsuzuki et al.	257/747
	M	US-5,156,322 ✕	10-1992	Do-Thoi et al.	228/124.1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP-10-102283-A	04-1998	Japan	Obata et al.	
*	O	JP-09-293958-A	11-1997	Japan	Sato	
*	P	JP-02-270990-A	11-1990	Japan	Murata et al.	
	Q	DT-2340423-A! ✕	02-1975	Germany	Siemens AG	
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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